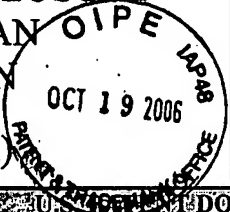


INFORMATION DISCLOSURE CITATION IN AN APPLICATION (PTO/SB/O8A)				ATTY. DOCKET NO. 2038-324		U.S. PATENT APPLICATION NO. 10/824,419	
				APPLICANT Takaaki SHIMADA et al.			
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U.S. PATENT DOCUMENTS													
EXAMINER'S INITIALS	PATENT NO.	DATE	NAME	CLASS	SUBCLASS	FILING DATE							
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EXAMINER'S INITIALS	PATENT NO.	DATE	COUNTRY	Abstract	Translation	Equivalent							
CA	2002-035033	2/2002	JP	_____	_____	_____							
CA	48-20638U	3/1973	JP	_____	_____	_____							
CA	63-32516U	3/1988	JP	_____	_____	_____							
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CA	3196874	7/1965	Hrubecky				
	3710797	1/1973	Marsan				
	3724464	4/1973	Enloe				
	3744494	7/1973	Marsan				
	3860004	1/1975	Nystrand				
	4067336	1/1978	Johnson				
	4636207	1/1987	Buell				
	4675012	6/1987	Rooyakkers				
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	5021051	6/1991	Hiuke				
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	6165160	12/2000	Suzuki et al.				
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	6440117	8/2002	Itoh et al.				
	6613955	9/2003	Lindsay et al.				
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	20020068919	6/2002	Shinohara et al.				
✓	20030163108	8/2003	Tears et al.				
FOREIGN PATENT DOCUMENTS							
EXAMINER'S INITIALS	PATENT NO.	DATE	COUNTRY	Abstract	Translation	Equivalent	
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CWT	20050004545	1/2005	Shimada et al.	/	1				
↓	20050004548	1/2005	Otsubo et al.	/	1				
	20050131375	6/2005	Sasaki et al.	/					
	20050143711	6/2005	Otsubo et al.	/					
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CWT	1177782	2/2002	EP	/	1				
↓	5021845	3/1975	JP	/	1				
	11188062	7/1999	JP	/	1				
	2003220091	8/2003	JP	/	1				
	2003230594	8/2003	JP	/	1				
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